

QUERY CONTROL FORM

PA-IOC

RTIS USE ONLY

Application No. <u>10 698 270</u>	Prepared by <u>PAP</u>	Tracking Number <u>05975920</u>
Examiner-GAU <u>Kamen - 3747</u>	Date <u>7/19/04</u>	Week Date <u>7/5/04</u>
	No. of queries <u>1</u>	

JACKET

a. Serial No.	f. Foreign Priority	k. Print Claim(s)	<input checked="" type="checkbox"/> PTO-1449
b. Applicant(s)	g. Disclaimer	l. Print Fig.	q. PTOL-85b
c. Continuing Data	h. Microfiche Appendix	m. Searched Column	r. Abstract
d. PCT	i. Title	n. PTO-270/328	s. Sheets/Figs
e. Domestic Priority	j. Claims Allowed	o. PTO-892	t. Other

SPECIFICATION

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- c. Holes through Data
- d. Other Missing Text
- e. Illegible Text
- f. Duplicate Text
- g. Brief Description
- h. Sequence Listing
- i. Appendix
- j. Amendments
- k. Other

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- k. Other

Thank you

initials PAP

RESPONSE

initials

Notice of References Cited

Application/Control No.

10/698,270

Applicant(s)/Patent Under
Reexamination
MEMMOTT ET AL.

Examiner

Noah Kamen

Art Unit

3747

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,245,977	09-1993	Chen et al.	123/590
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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